

<b>Search Notes</b>	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/720,389	MIYAKE ET AL.
Examiner	Art Unit	
Tho D. Ta	2833	

<b>INTERFERENCE SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
see printout		12/29/2005	TDT